

Search Notes

Application/Control No.

10/522,194

Examiner

Tam M. Nguyen

Applicant(s)/Patent under
Reexamination

HIIL ET AL.

Art Unit

1764

SEARCHED

Class	Subclass	Date	Examiner
585	809 810	10/11/2007	TN
208	347	10/11/2007	tn
203	74	10/11/2007	TN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	10/11/2007	TN
inventors searched in EDAN	10/11/2007	tn